

High Temperature Silicon Carbide Power Schottky Diode

V_{RRM}	=	650 V
V_F	=	1.3 V
I_F	=	2.5 A
Q_C	=	20 nC

Features

- 650 V Schottky rectifier
- 250 °C maximum operating temperature
- Electrically isolated base-plate
- Zero reverse recovery charge
- Superior surge current capability
- Positive temperature coefficient of V_F
- Temperature independent switching behavior
- Lowest figure of merit Q_C/I_F
- Available screened to Mil-PRF-19500

Advantages

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

Maximum Ratings at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V _{RRM}		650	V
Continuous forward current	I _F	T _C ≤ 225 °C	2.5	A
RMS forward current	I _{F(RMS)}	T _C ≤ 225 °C	4.3	A
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	T _C = 25 °C, t _p = 10 ms	32	A
Non-repetitive peak forward current	I _{F,max}	T _C = 25 °C, t _p = 10 μs	120	A
i ² t value	∫i ² dt	T _C = 25 °C, t _p = 10 ms	5	A ² S
Power dissipation	P _{tot}	T _C = 25 °C	66	W
Operating and storage temperature	T _j , T _{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode forward voltage	V _F	I _F = 2.5 A, T _j = 25 °C	1.3			V
		I _F = 2.5 A, T _j = 210 °C	1.7			
Reverse current	I _R	V _R = 650 V, T _j = 25 °C	0.12	5		μA
		V _R = 650 V, T _j = 250 °C	7.5	30		
Total capacitive charge	Q _C	I _F ≤ I _{F,MAX}	20			nC
Switching time	t _s	dI _F /dt = 200 A/μs	V _R = 400 V	< 25		ns
		T _j = 210 °C	V _R = 400 V			
Total capacitance	C	V _R = 1 V, f = 1 MHz, T _j = 25 °C	274			
		V _R = 400 V, f = 1 MHz, T _j = 25 °C	31			pF
		V _R = 800 V, f = 1 MHz, T _j = 25 °C	29			

Thermal Characteristics

Thermal resistance, junction - case	R _{thJC}	3.4	°C/W
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Mechanical Properties

Mounting torque	M	0.6	Nm
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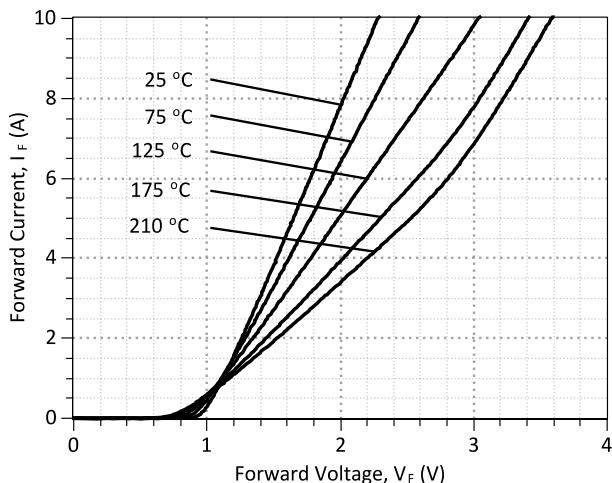


Figure 1: Typical Forward Characteristics

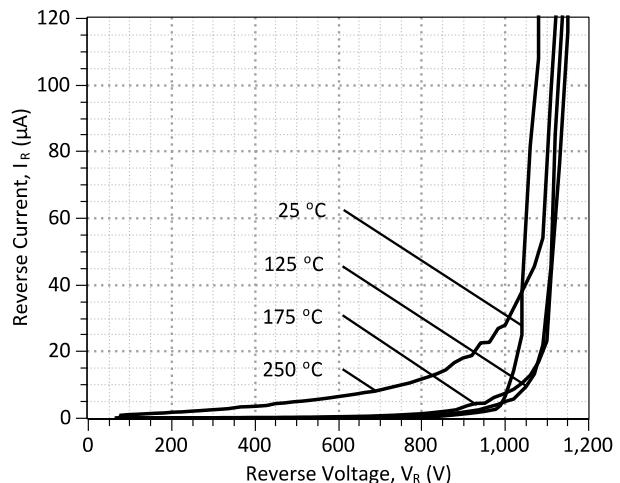


Figure 2: Typical Reverse Characteristics

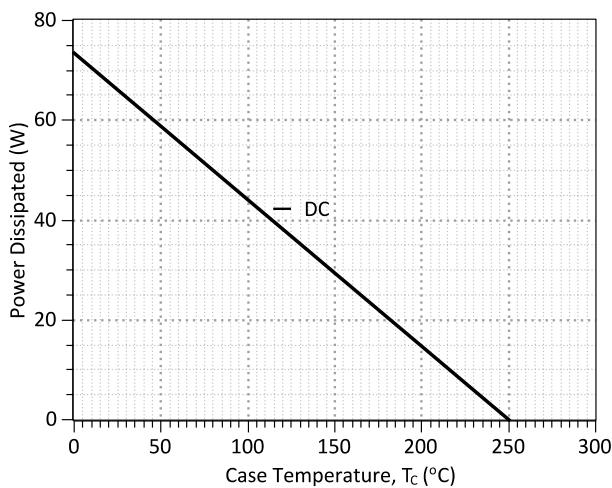


Figure 3: Power Derating Curve

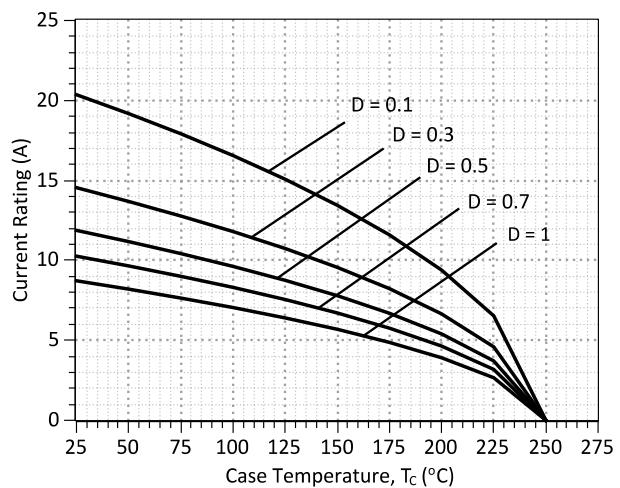


Figure 4: Current Derating Curves ($D = t_p/T$, $t_p = 400 \mu s$)
 (Considering worst case Z_{th} conditions)

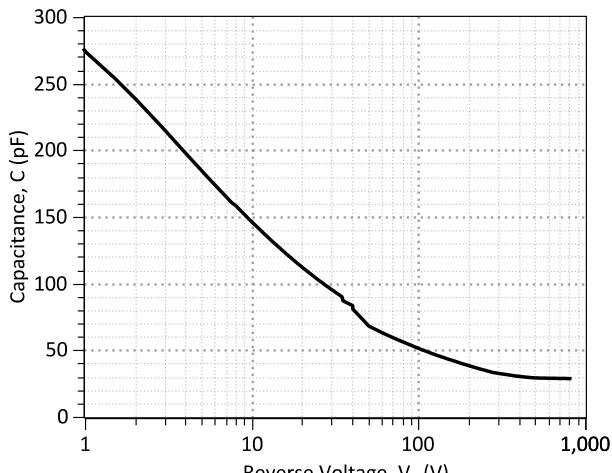


Figure 5: Typical Junction Capacitance vs Reverse Voltage Characteristics

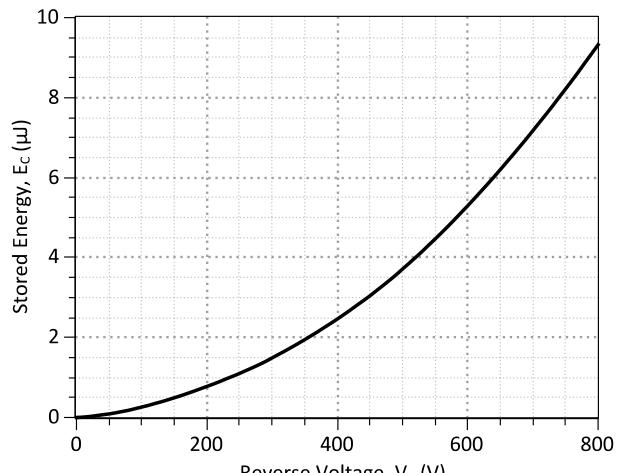


Figure 6: Typical Switching Energy vs Reverse Voltage Characteristics

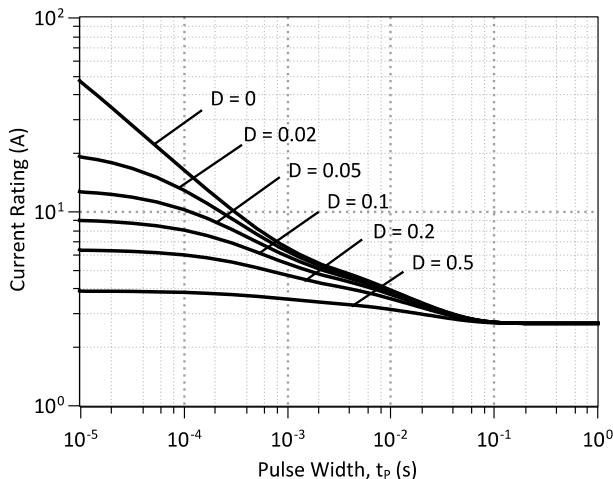


Figure 7: Current vs Pulse Duration Curves at $T_c = 225\text{ }^\circ\text{C}$

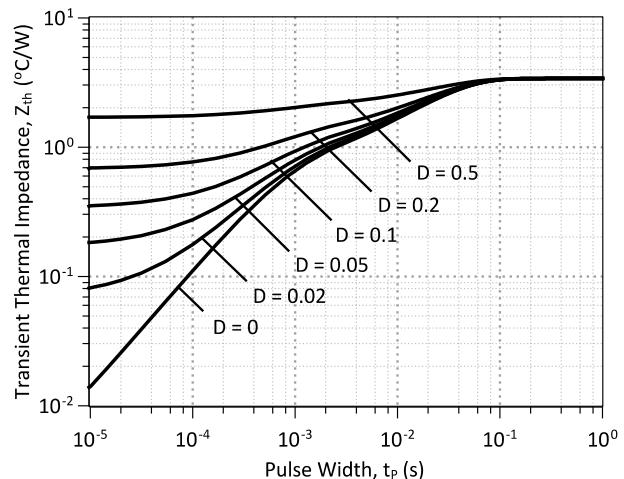
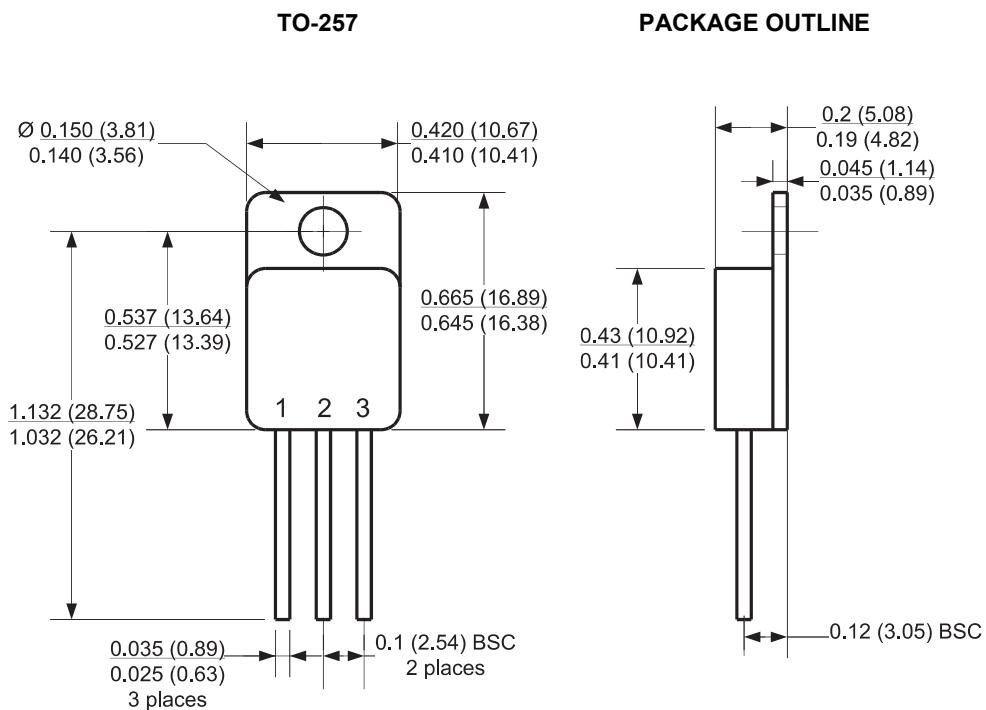


Figure 8: Transient Thermal Impedance

Package Dimensions:



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2012/04/24	0	Initial release	

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43670 Trade Center Place Suite 155
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